
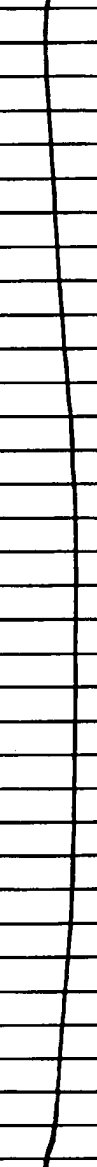



5/16/07

Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty Docket No.	IGT1P369D1/SH-052 DIV
	Application No.:	10/827,042
	Applicant	Martinek et al.
	Filing Date	April 19, 2004
	Group	3714
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Examiner <i>Percut</i>	Date Considered <i>8/17/07</i>
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.